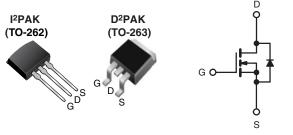


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	500			
R _{DS(on)} (Max.) (Ω)	V _{GS} = 10 V	1.40		
Q _g (Max.) (nC)	24			
Q _{gs} (nC)	6.3			
Q _{gd} (nC)	11			
Configuration	Single			



N-Channel MOSFET

FEATURES

• Halogen-free According to IEC 61249-2-21 **Definition**



 Low Gate Charge Q_q Results in Simple Drive RoHS Requirement



• Improved Gate, Avalanche and Dynamic dV/dt Ruggedness



- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective Coss specified
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High speed power switching

TYPICAL SMPS TOPOLOGIES

- Two Transistor Forward
- Half Bridge and Full Bridge

ORDERING INFORMATION					
Package	D ² PAK (TO-263)	D ² PAK (TO-263)	I ² PAK (TO-262)		
Lead (Pb)-free and Halogen-free	SiHF830AS-GE3	SiHF830ASTRL-GE3 ^a	SiHF830AL-GE3 ^a		
Lead (Pb)-free	IRF830ASPbF	IRF830ASTRLPbFa	IRF830ALPbF		
	SiHF830AS-E3	SiHF830ASTL-E3 ^a	SiHF830AL-E3		
SnPb	IRF830AS	IRF830ASTRL ^a	IRF830AL		
	SiHF830AS	SiHF830ASTLa	SiHF830AL		

Note

a. See device orientation.

ABSOLUTE MAXIMUM RATINGS (T_{C}	= 25 °C, un	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	V	
Gate-Source Voltage			V_{GS}	± 30	- V	
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$	I-	5.0		
		T _C = 100 °C	ID	3.2	Α	
Pulsed Drain Current ^{a, e}			I _{DM}	20		
Linear Derating Factor				0.59	W/°C	
Single Pulse Avalanche Energy ^{b, e}			E _{AS}	230	mJ	
Avalanche Current ^a			I _{AR}	5.0	Α	
Repetiitive Avalanche Energy ^a			E _{AR}	7.4	mJ	
Maximum Power Dissipation	T _A = 25 °C		P _D	3.1	W	
	T _C =	: 25 °C	r _D	74	7 vv	
Peak Diode Recovery dV/dtc, e		dV/dt	5.3	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d	1	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting $T_J = 25$ °C, L = 18 mH, $R_g = 25 \Omega$, $I_{AS} = 5.0$ A (see fig. 12).
- c. $I_{SD} \le 5.0$ A, $dI/dt \le 370$ A/ μ s, $V_{DD} \le V_{DS}$, $T_{J} \le 150$ °C.
- d. 1.6 mm from case.
- e. Uses SiHF830A data and test conditions.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRF830AS, IRF830AL, SiHF830AS, SiHF830AL

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient (PCB Mounted, Steady-State) ^a	R _{thJA}	-	40	°C/W	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	1.7		

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	TEST CONDITIONS			MAX.	UNIT
Static		-					
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA		500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA ^d	-	0.60	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} :	= V _{GS} , I _D = 250 μA	2.0	-	4.5	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 30 \text{ V}$	-	-	± 100	nA
Zava Cata Valtaga Dwain Current		V _{DS} :	V _{DS} = 500 V, V _{GS} = 0 V		-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 3.0 \text{ A}^b$	-	-	1.4	Ω
Forward Transconductance	9fs	V _{DS} = 50 V, I _D = 3.0 A ^d		2.8	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		-	620	-	
Output Capacitance	C _{oss}			-	93	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.	f = 1.0 MHz, see fig. 5 ^d		4.3	-	
Output Capacitance	C _{oss}	V _{GS} = 0 V	V _{DS} = 1.0 V, f = 1.0 MHz	-	886	-	
			V _{DS} = 400 V, f = 1.0 MHz	-	27	-	
Effective Output Capacitance	C _{oss} eff.		V _{DS} = 0 V to 400 V ^{c, d}	-	39	-	
Total Gate Charge	Q_g		I _D = 5.0 A, V _{DS} = 400 V, see fig. 6 and 13 ^{b, d}	-	-	24	
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V		-	-	6.3	nC
Gate-Drain Charge	Q _{gd}		See lig. 0 and 13		-	11	
Turn-On Delay Time	t _{d(on)}		'		10	-	
Rise Time	t _r		= 250 V, I _D = 5.0 A,	-	21	-	200
Turn-Off Delay Time	t _{d(off)}	$R_g = 14 \stackrel{\frown}{\Omega}, R_D = 49 \stackrel{\frown}{\Omega}, \text{ see fig. } 10^{b, d}$		-	21	-	ns _
Fall Time	t _f			-	15	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		i	ı	5.0	A
Pulsed Diode Forward Current ^a	I _{SM}			-	ı	20	
Body Diode Voltage	V_{SD}	T _J = 25 °C	$T_J = 25 ^{\circ}\text{C}, I_S = 5.0 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 5.0 A, dl/dt = 100 A/μs ^{b, d}		-	430	650	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.0	3.0	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_C				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %. c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80 % V_{DS} .
- d. Uses SiHF830A data and test conditions.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

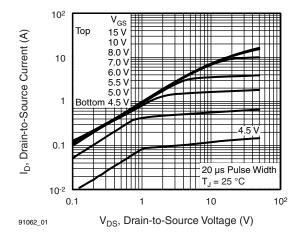


Fig. 1 - Typical Output Characteristics

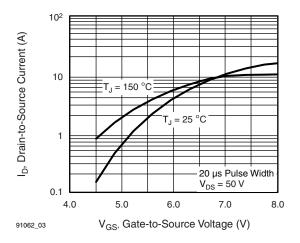


Fig. 3 - Typical Transfer Characteristics

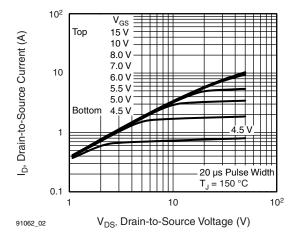


Fig. 2 - Typical Output Characteristics

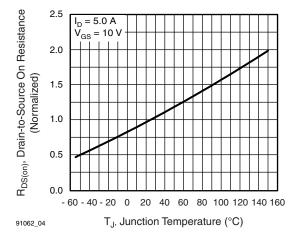


Fig. 4 - Normalized On-Resistance vs. Temperature

IRF830AS, IRF830AL, SiHF830AS, SiHF830AL

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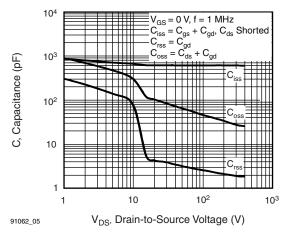


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

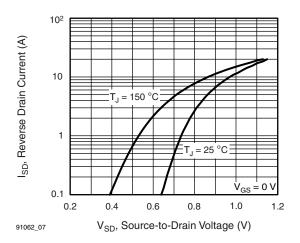


Fig. 7 - Typical Source-Drain Diode Forward Voltage

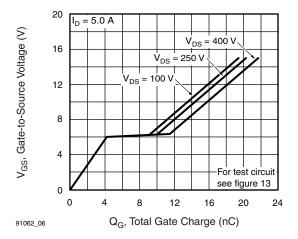


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

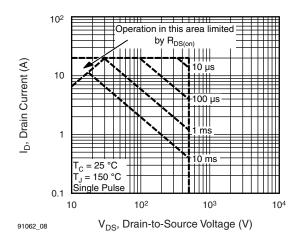


Fig. 8 - Maximum Safe Operating Area



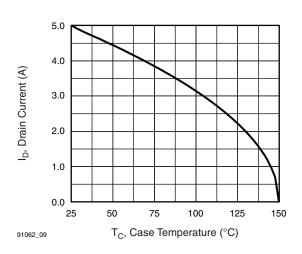


Fig. 9 - Maximum Drain Current vs. Case Temperature

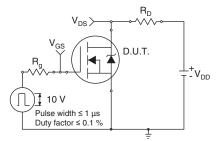


Fig. 10a - Switching Time Test Circuit

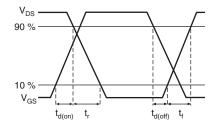


Fig. 10b - Switching Time Waveforms

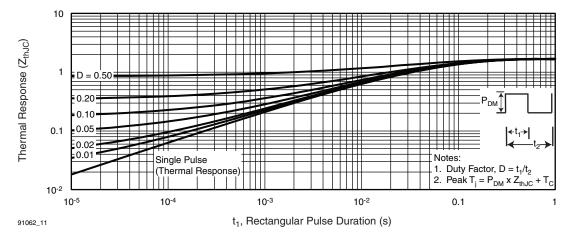


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

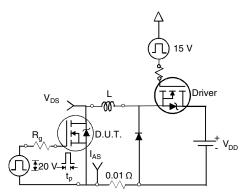


Fig. 12a - Unclamped Inductive Test Circuit

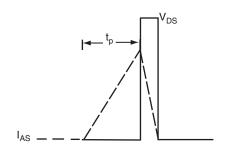


Fig. 12b - Unclamped Inductive Waveforms

IRF830AS, IRF830AL, SiHF830AS, SiHF830AL

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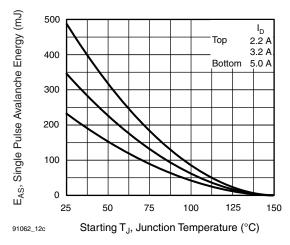


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

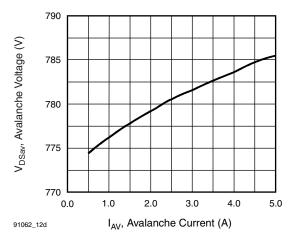


Fig. 12d - Basic Gate Charge Waveform

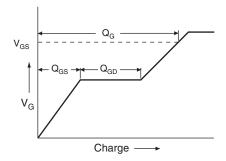


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

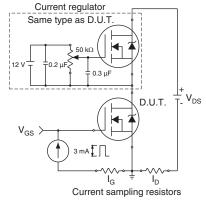
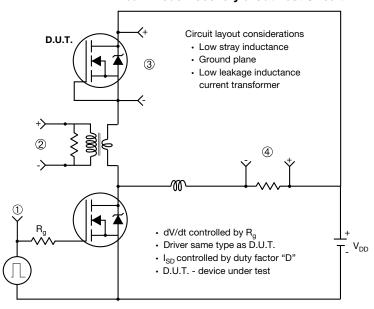


Fig. 13b - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit



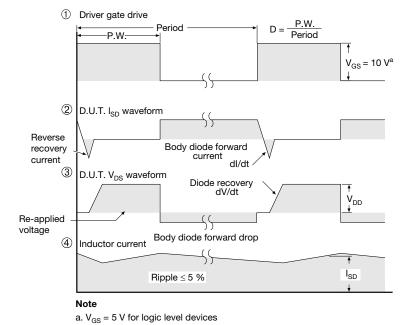


Fig. 14 - For N-Channel

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